

Advances in Microprocessor-Based Distribution Relays

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INTRODUCTION

Advanced microprocessor-based distribution relays have features that improve distribution protection and aid in event analysis and testing [References 1, 2, 3, and 4]. Significant relay advancements also handle system disturbances, relay failures, changes in protection philosophy, and changing system conditions.

SYSTEM DISTURBANCES AND EVENT REPORTING

Recreating the sequence of events for a distribution system disturbance with information available from traditional distribution protection equipment is difficult at best. In most instances, targets are the only source of information. Targets can show phase involvement and relative fault current magnitudes (did the instantaneous element operate?), but no time sequence or precise fault current magnitude information. If targets are not reset from a previous operation, the confusion is compounded when the next disturbance occurs.

Sequence-of-events recorders and oscillograms are generally considered too expensive for distribution applications. An experienced operator must interpret oscillogram output.

Technicians now quickly retrieve event reports from advanced distribution relays locally or by telephone modem and review every operation. Event reports simplify event analysis by combining currents, voltages, relay elements, and contact I/O in one report.

Event Report Advantages

- One report contains all information -- several cycles worth.
- One report fits on one or two sheets of paper.
- Report retrieval is fast: only 30 seconds at 1200 baud.
- Event reporting is essentially free: it is part of the relay, and digital relays cost less than electromechanical or static analog relays.

System Knowledge Increased

- Sequence-of-events data are now available at all voltages and points in the system.
- We no longer need to rely on oscillographic data that may be available one or two stations away from the fault.

- The phasor voltage and current data, along with fault location, are being used to verify and improve system modeling.
- Scheme performance is easy to ascertain from the detailed data available after each operation. This is an aid in testing, also.

System Problems Discovered

- Instrument transformer ratio and polarity errors
- Instrument transformer failures
- High-resistance fault analysis
- Repeated failures to synchronize a generator
- Calculation of zero-sequence impedance of lines

Reference 5 reviews some event reports and illustrates practical analytical tools. An example event report is given in Figure 1.

SHOULD SELF TESTING AND EVENT REPORTING CHANGE TESTING PHILOSOPHY?

Well-designed digital relays use fewer components than electromechanical or static analog designs, and thus provide more reliable protection. Failures can still occur, however. In the remote chance that a failure does occur, automatic self testing is almost certain to detect the problem and send operators an alarm via SCADA, etc. The result is much improved relay availability. Before digital relays, routine tests (or misoperations) were the only indicators of electromechanical and most solid-state relay problems.

Relays with automatic self testing and event reporting require less testing to ensure they are operating properly. Technicians can now better allocate their limited resources to relays without self testing and to analyzing event reports from relays having event reporting. When technicians review relay event reports, they are reviewing data from a test of the system created by a real fault. Technicians add more value to the electric power system, because they are checking not only the relay, but the surrounding equipment. Did the relay get proper voltages and currents? Did the circuit breaker auxiliary contact respond correctly?

CHANGES IN PROTECTION PHILOSOPHY AND PROGRAMMABLE LOGIC

Protection schemes are constantly being modified and improved. Changing traditional protection schemes often requires purchasing and installing additional equipment.

Philosophy of distribution protection changes over time and differs from company to company; sometimes from location to location within the same company. If a distribution relay meets one company's requirements, it may not satisfy another's. Making factory modifications to satisfy different companies is costly, time consuming, and results in "one-of-a-kind" relays.

Relay design engineers devised user-programmable logic for new distribution relays. This logic handles future protection schemes as well as the multiplicity of protection schemes that protect different companies' distribution systems. With these new relays, there is less need for additional equipment as protection schemes are enhanced.

Internal relay elements (e.g., overcurrent, voltage) can be programmed to control output contacts. This flexibility aids technicians in "isolating" and testing relay elements.

Programmable Logic Example

In the following example, relay opto-isolated input IN6 supervises the ground overcurrent elements (51NT and 50NLT) for tripping. Input IN6 can be de-energized during circuit paralleling operations to prevent the ground overcurrent elements from initiating a trip on temporary current unbalance. Figure 2 shows the example in relay logic form.

$A = 51NT + 50NLT$ If 51NT or 50NLT assert, "A" asserts.

$E = IN6$ If input IN6 is energized with nominal control voltage, variable E asserts.

$V = A * E$ If both variables A and E are asserted at the same time, variable V asserts.

Effectively, $V = (51NT + 50NLT) * IN6$.

$TR = 51T + V$ TR is the TRIP output contact programmable trip variable. 51T is a phase overcurrent element. If 51T or V asserts, TR asserts.

Effectively, $TR = 51T + [(51NT + 50NLT) * IN6]$

Close TRIP output contact = TR + ...

CHANGING DISTRIBUTION SYSTEM AND MULTIPLE SETTING GROUPS

An electric power distribution system changes hourly to seasonally:

- Scheduled switching for construction or maintenance projects
- Emergency switching for repairs
- Bus-tie breakers substituting for distribution feeder breakers
- Seasonal load transfers

The resulting system reconfigurations last from hours to months. Many reconfigurations are repeated. The following problems can result:

- Major changes in load or unbalance
- Large variations in fault duties, due to source and feeder changes
- Coordination problems with different protective equipment
- Increased fault duty on conductor, cable, and equipment

Traditional protective equipment does not adapt readily to distribution system reconfigurations. If new settings are needed they have to be manually changed: there are no settings in reserve. The time to derive, enter, and test new settings slows down emergency responses and risks human error. Sometimes relay settings are not changed for emergency or abnormal switching, because it takes too long or is too difficult. System protection is compromised.

Advanced distribution relays handle system reconfigurations with multiple setting groups. A specific setting group can be enabled by:

- Command via communications port or
- Setting group selection inputs

Different setting groups can be programmed to cover many different contingencies. The optimal protection scheme and settings are enabled for highest service reliability.

Operational costs are reduced by not having to derive, enter, and test new settings. This is done conveniently in advance. For example, in a bus-tie circuit breaker application, the bus-tie relay stores the settings for the feeder relays it replaces (see Figure 3).

References 6 and 7 describe the first relay with multiple setting groups. In new distribution relays, the multiple setting group feature has been expanded to allow the programmable internal logic and output contact functions to change along with the relay element settings.

CONCLUSIONS

Event reports, self testing, programmable logic, and multiple setting group features in advanced microprocessor-based distribution relays improve distribution protection and aid in event analysis and testing.

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BIOGRAPHIES

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Currents A pri				Voltages V pri			P	Q	N	I	Out	In		
IR	IA	IB	IC	VA	VB	VC	555T 100C LHI	55 10 LH	555 100 LM	D E M	7B 9K R	T13A &&L C24R	135 &&& 246	
-5	-82	-288	362	-1613	-9533	11081	R.	B35	One cycle of data, prefault conditions
-0	382	-254	-122	11837	-7279	-4601	R.	B35	
5	77	288	-362	1606	9533	-11081	R.	B35	
-0	-379	254	122	-11830	7279	4601	R.	B35	
-5	-74	-288	362	-1606	-9540	11081	R.	B35	Both (B) inputs 1 and 2 are energized. Input 3 (3) is energized. Input 5 (5) is energized.
-0	374	-254	-122	11844	-7279	-4615	R.	B35	
5	79	288	-362	1591	9547	-11074	R.	B35	
-0	-377	254	122	-11851	7265	4637	R.	B35	
-5	-82	-288	362	-1577	-9554	11066	R.	B35	Reclosing relay (dev. 79) is in the reset state (R).
-0	379	-254	-122	11844	-7250	-4644	R.	B35	
5	79	288	-362	1562	9569	-11066	R.	B35	
-0	-379	254	122	-11837	7236	4644	R.	B35	
-7	-77	-288	362	-1555	-9569	11066	R.	B35	Overcurrent elements pick up (p) at phase A-to-ground fault inception and start timing.
2	379	-254	-125	11844	-7236	-4658	R.	B35	
124	192	283	-355	1570	9569	-11066	R.	B35	
277	-82	228	132	-10800	6818	4349	p..	.	R.	B35	
-1153	-1200	-252	314	-1519	-9634	11066	p...	p.	pp.	.	R.	B35	Ground overcurrent element 50NLT times out after 3 cycles ("p" changes to "T"). 50NLT enabled for tripping. TRIP output contact asserts (T).
-226	84	-190	-120	8575	-5904	-3686	p...	p.	pp.	.	R.	B35	
2318	2338	218	-269	1361	9742	-11023	p...	p.	pp.	.	R.	B35	
-153	-425	178	98	-7265	5342	3298	p...	p.	pp.	.	R.	B35	
-2600	-2614	-211	257	-1246	-9799	10987	p...	p.	pp.	.	R.	B35	Reclosing relay is in the reclose cycle state (C).
204	470	-178	-96	7106	-5256	-3254	p...	p.	pp.	.	R.	B35	
2639	2650	211	-254	1217	9814	-10987	p...	p.	pp.	.	R.	B35	
-212	-478	178	96	-7078	5242	3262	p...	p.	pp.	.	R.	B35	
-2646	-2654	-211	254	-1210	-9821	10980	p...	p.	pp.	.	R.	B35	Circuit breaker auxiliary contact (52A) opens and input 5 is de-energized (input IN5=52A).
216	482	-178	-96	7070	-5242	-3276	p...	p.	pp.	.	R.	B35	
2646	2654	211	-254	1210	9821	-10973	p...	p.	pp.	.	R.	B35	
-221	-487	175	96	-7070	5227	3290	p...	p.	pp.	.	R.	B35	
-2646	-2652	-211	254	-1202	-9821	10973	p...	p.	pT.	.	R.	T...	B35	Overcurrent elements drop out after circuit breaker clears fault.
224	490	-173	-96	7070	-5213	-3298	p...	p.	pT.	.	R.	T...	B35	
2646	2650	211	-254	1188	9835	-10973	p...	p.	pT.	.	C.	T.3.	B35	
-224	-490	173	96	-7070	5206	3305	p...	p.	pT.	.	C.	T.3.	B35	
-2646	-2652	-209	254	-1181	-9850	10966	p...	p.	pT.	.	C.	T.3.	B35	Event Summary - includes fault location
226	494	-175	-96	7070	-5191	-3312	p...	p.	pT.	.	C.	T.3.	B35	
2527	2532	199	-242	1159	9850	-10958	p...	p.	pT.	.	C.	T.3.	B35	
-504	-710	110	106	-8129	5602	3650	p...	p.	pT.	.	C.	T.3.	B35	
-1491	-1498	-115	144	-1166	-9799	10951	p...	p.	pT.	.	C.	T.3.	B3.	Event Summary - includes fault location
438	521	-26	-65	10354	-6509	-4342	p...	p.	pT.	.	C.	T.3.	B3.	
326	331	24	-34	1289	9713	-10966	p.	pT.	.	C.	T.3.	B3.	
-56	-70	5	10	-11678	7049	4745	pT.	.	C.	T.3.	B3.	
-44	-43	-5	5	-1382	-9677	10987	C.	..3.	B3.	Event Summary - includes fault location
7	12	0	-2	11844	-7099	-4802	C.	..3.	B3.	
7	5	0	0	1382	9684	-10987	C.	..3.	B3.	
-0	-2	0	0	-11858	7092	4810	C.	..3.	B3.	
Event : AG T Location: 2.45 Shot: 0 Targets: INSTAQN														Event Summary - includes fault location
Currents (A pri), ABCQN: 2698 274 271 2616 2655														

Figure 1: Example Event Report

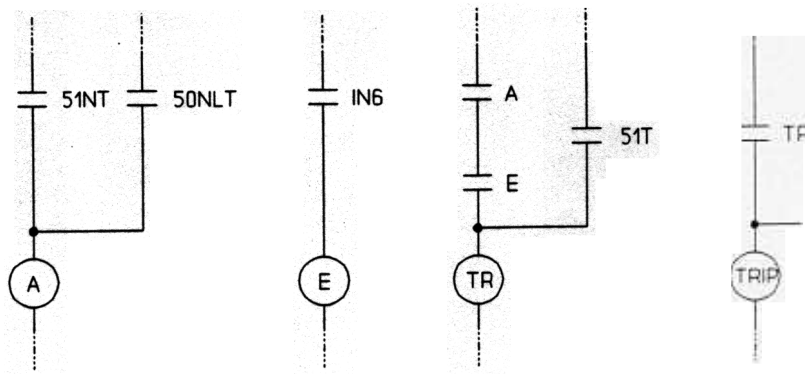


Figure 2: Relay Logic Representation of Programmable Logic Example

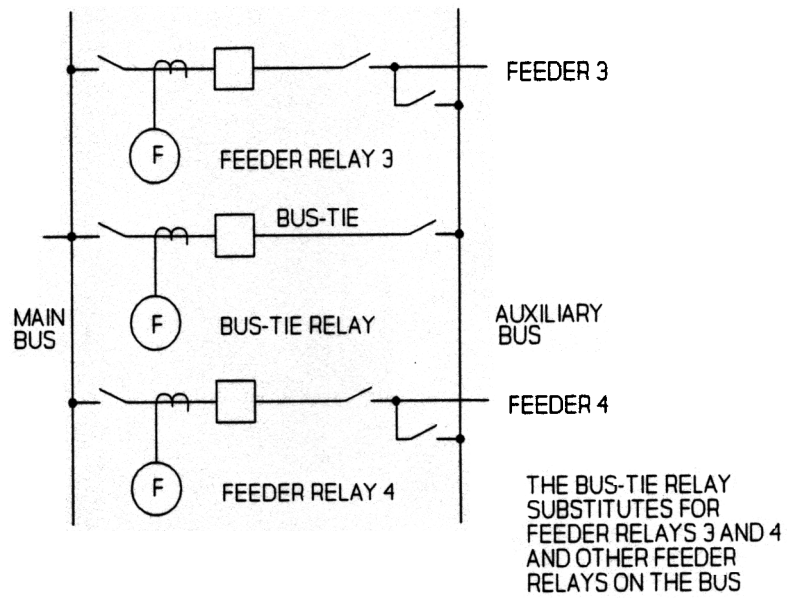


Figure 3: Bus-tie Breaker Substitutes for Distribution Feeder Breakers